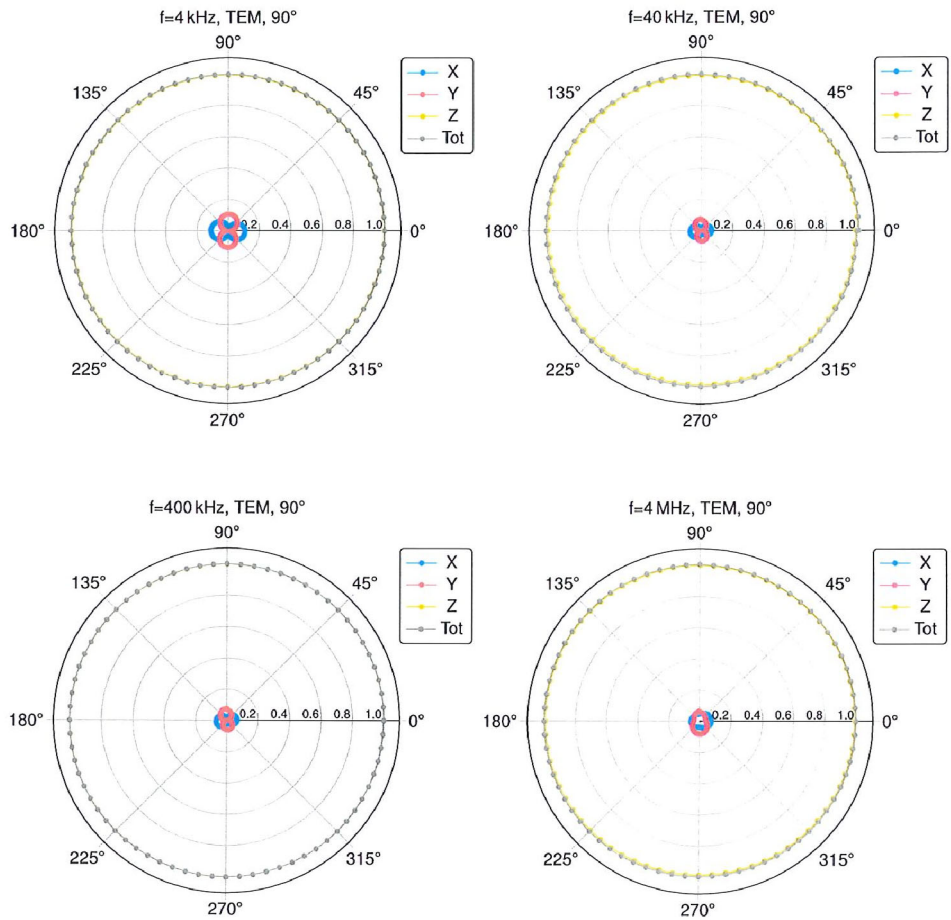

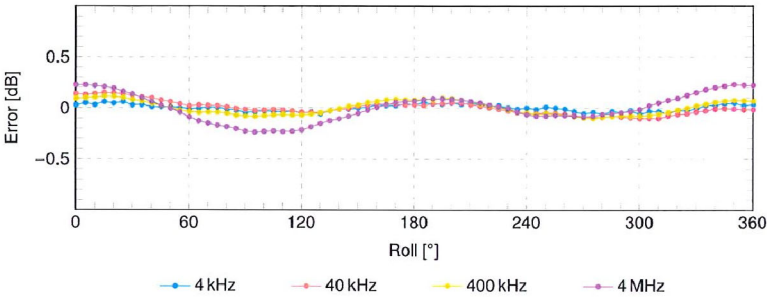


H-Field Receiving Pattern (ϕ), $\vartheta = 90^\circ$

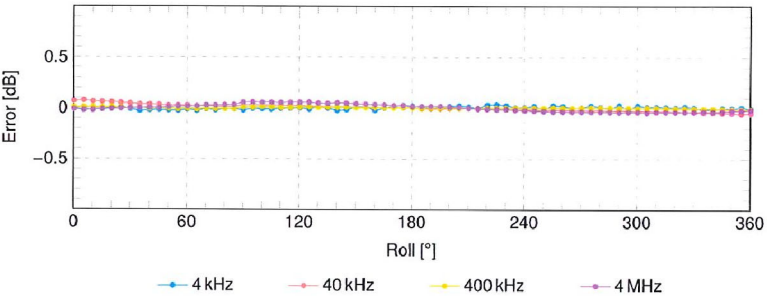


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H-Field Receiving Pattern (ϕ), $\theta = 0^\circ$



H-Field Receiving Pattern (ϕ), $\theta = 90^\circ$



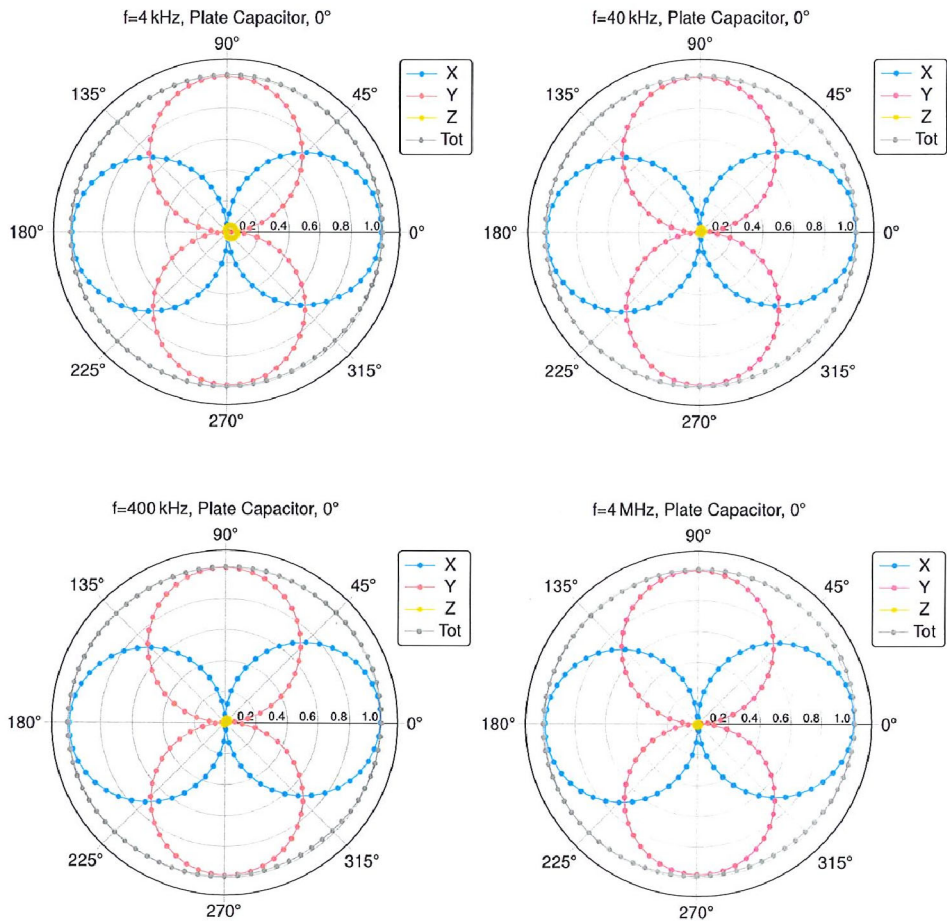
SPEAG axial deviation from the ideal response tolerance for H-field: ± 0.6 dB


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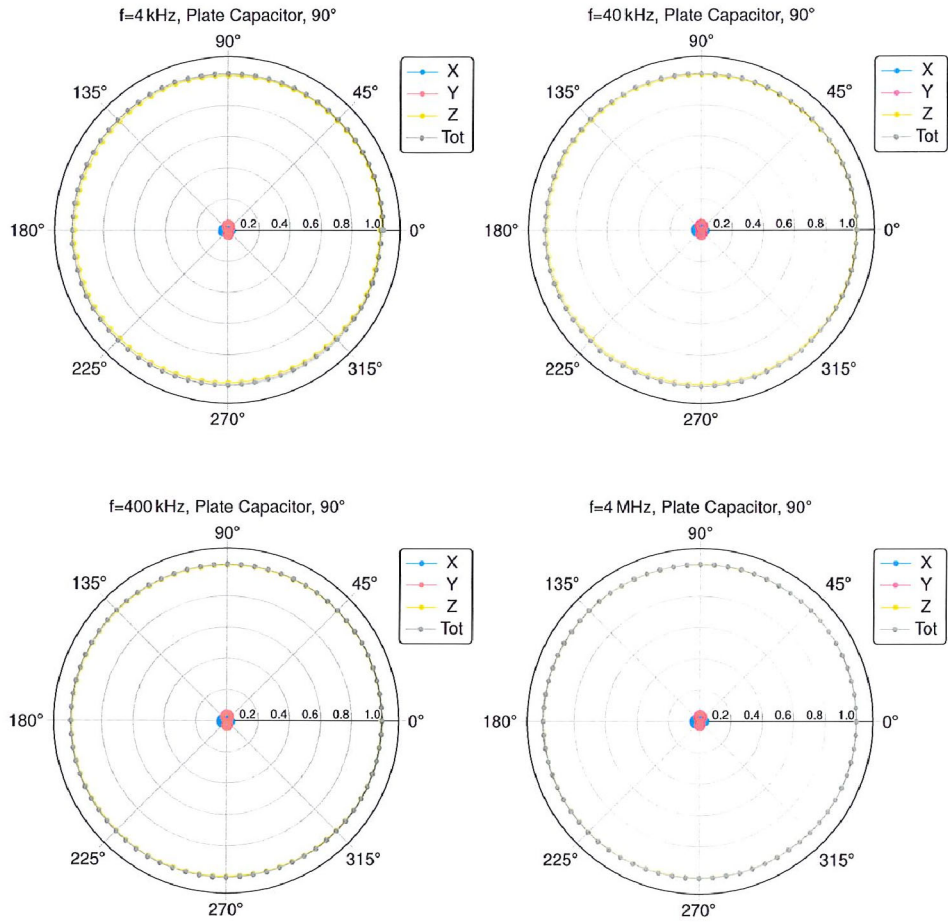
Isotropy E-Field


E-Field Receiving Pattern (ϕ , $\vartheta = 0^\circ$)



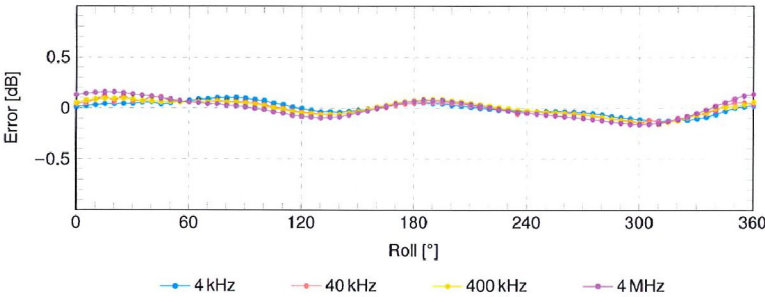
FCC ID: A3LSMS938B		WPT RF EXPOSURE EVALUATION REPORT	Reviewed by: Quality Manager
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E-Field Receiving Pattern (ψ), $\vartheta = 90^\circ$

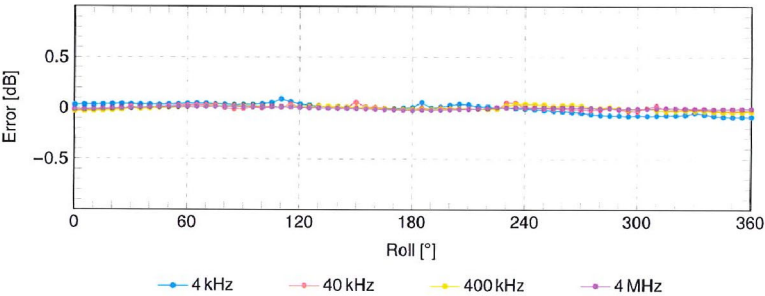


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E-Field Receiving Pattern (ϕ), $\vartheta = 0^\circ$



E-Field Receiving Pattern (ϕ), $\vartheta = 90^\circ$



SPEAG axial deviation from the ideal response tolerance for E-field: ± 0.8 dB

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